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Context

- Safety-critical software
- **Design** of fault-tolerant software known to be difficult, and very often ad-hoc.
- **Validation** is expensive – running of a lot of experiments.
- May still end up with **“inefficient”** software, e.g., false alarms, late error detection.

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- **Title: A Framework for the Design and Validation of Efficient Fail-Safe Fault-Tolerant Software**
- **Presentation outline:**
 - Background
 - Problems and Objectives
 - Design of efficient fail-safe fault-tolerant SW
 - Test case generation for validation of efficient fail-safe fault-tolerant SW
 - Summary

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Background (1)

- **Fault:** An unexpected event, e.g., node crashes, variable corruptions. Each one is a **fault class**.
- **Fault-tolerant** program: Satisfies some form of **correctness** in presence of **faults**.
- Different levels of fault tolerance
 - Masking fault tolerance (ideal)
 - **Fail-safe fault tolerance**

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Background (2)

- **Correctness:** Specification
- **Safety:** **“always...”**
 - mutual exclusion, **always** (output > 100)
- **Liveness:** **“eventually...”** -- Termination
- A **fail-safe fault-tolerant** program always satisfies its safety specification in presence of faults. Ok to just stop.

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Fail-Safe Fault Tolerance

- Detection is important in fault tolerance
- **Detector** – A program component that checks the **validity of a predicate**, e.g., assertion checks, comparator.
- Arora & Kulkarni, 1998 – **detectors** are both necessary and sufficient to ensure fail-safeness

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Assumptions

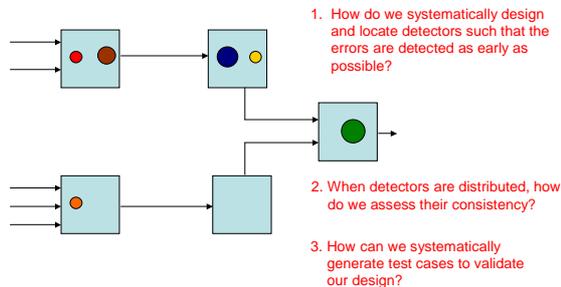
- Bounded programs – finite number of states, e.g., embedded programs. Can be achieved via proper subtyping.
- Logically (and physically) distributed software.
- Source code available.

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General Problems



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Goals

- Fail-safe fault-tolerant program able to
 - ∇ Detect all harmful errors
 - ∇ No false alarms
 - ∇ Detect errors early
- Test cases for validation of fail-safe fault-tolerant program

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Transformational Approach

- Fault-intolerant program P (viewed as a state machine)
 - Safety specification $SSPEC$
 - Fault class F
- ⊔ Obtain fail-safe F -tolerant program P'
- P' always satisfy $SSPEC$ in presence of F +
 - P' has minimal detection latency for F

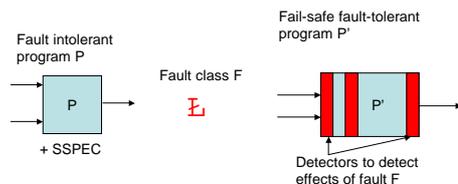
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Graphical Illustration

- Transform fault-intolerant program P into a fail-safe fault-tolerant program P' , with minimal detection latency.

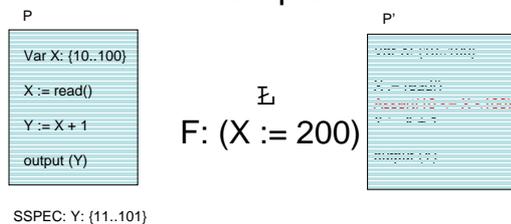


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Example



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Some Advantages

- Separation of concern between design for **functionality (P)** and for **fault tolerance (P')**
- Modular – different fault classes can be considered

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Detector Role

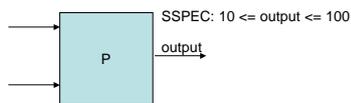
- **Harmful event**: e.g., output > 100.
- Safety specification: defines a set of harmful events.
- Prevent the occurrence of **harmful** events.

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Safety Specification



Example of a bad event: Any program transition that allows output to violate SSPEC, ($\langle \text{output} = 90 \rangle$, $\langle \text{output} = 110 \rangle$)

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Formal Design Approach

- Given:
Program **P**, safety specification **SSPEC**, and fault class **F**.
- Goal: Compose **P** with a set of detectors **D** such that **P'** = **P**||**D** (i) is fail-safe **F**-tolerant, and (ii) has minimal detection latency for **F**.

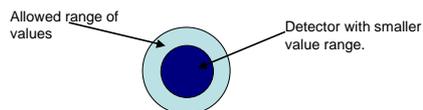
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Detector Design (1)

- A detector can be too strong – it filters out harmless events.



- Leads to false alarms!

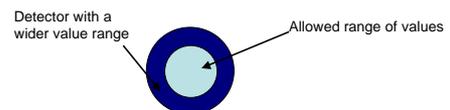
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Detector Design (2)

- A detector can be too weak – it does not filter out all harmful events.



- Can have catastrophic consequences!

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Perfect Detectors

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Detector Design (3)

- We want a detector to (i) detect all harmful events, (ii) have no false positives.
- Such a detector is **perfect**.
- Thus, we need a set of perfect detectors **D**.

\exists We compose **P** with a set **D** of perfect detectors, yielding **P'**.

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Detector Design (4)

- Given program **P**, its safety spec. (set of harmful events) **SSPEC**, and fault class **F**.
- Perform a backward propagation operation along information flow to yield potentially harmful events, i.e., events that can lead to occurrence of harmful events.
- A set of perfect detectors is obtained.

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Approach - Graphically

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Backward Propagation

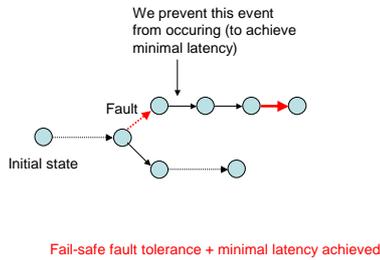
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Backward Propagation (1)

Consider the state transition view of a program

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Backward Propagation (2)



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Properties of P'

- Perfect coverage
 - ⊆ No false alarm, rejects all harmful events.
- Minimal detection latency.

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Where are we?

- Objective: Design of fail-safe fault-tolerant program with minimal detection latency.
- Perfect detectors are important.
- Use of a backward propagation operation to generate a set of perfect detectors.

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What next?

- Have to ascertain that what we have is right (**validation**), i.e., check if program is indeed fail-safe fault-tolerant, with minimal detection latency.
- Different methods:
 - (i) Testing
 - (ii) Fault injection
- Need test cases for this.

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Test Case Generation

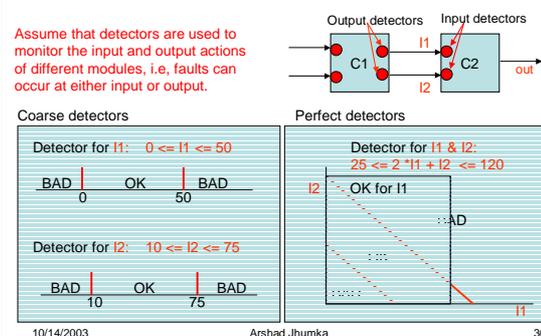
- Early: ad-hoc approach, random sampling.
- **Our approach:** We use detector design decisions to generate test cases.

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Test Case Generation



Summary

- Program-transformation based approach to design fail-safe fault-tolerant program + minimal latency.
- Addition of perfect detectors.
- Use of perfect detector design for test case generation.

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